
	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report			Page 1(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID

APPENDIX D: PROBE & DIPOLE CALIBRATION DATA

	Document		Page	
	Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report		2(20)	
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	March 24-26, 2014 December 8-12, 2014	RTS-6046-1404-01Rev 2	L6ARFX100LW	

Probe 3592

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **Blackberry Waterloo**

Certificate No: **EX3-3592_Nov14**

CALIBRATION CERTIFICATE

Object **EX3DV4 - SN:3592**

Calibration procedure(s) **QA CAL-01.v9, QA CAL-14.v4, QA CAL-23.v5, QA CAL-25.v6**
Calibration procedure for dosimetric E-field probes

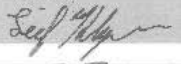

Calibration date: **November 10, 2014**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TC critical for calibration)


Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	03-Apr-14 (No. 217-01911)	Apr-15
Power sensor E4412A	MY41488087	03-Apr-14 (No. 217-01911)	Apr-15
Reference 3 dB Attenuator	SN: S5054 (3c)	03-Apr-14 (No. 217-01915)	Apr-15
Reference 20 dB Attenuator	SN: S5277 (20x)	03-Apr-14 (No. 217-01919)	Apr-15
Reference 30 dB Attenuator	SN: S5129 (30b)	03-Apr-14 (No. 217-01920)	Apr-15
Reference Probe ES3DV2	SN: 3013	30-Dec-13 (No. ES3-3013_Dec13)	Dec-14
DAE4	SN: 660	13-Dec-13 (No. DAE4-660_Dec13)	Dec-14
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-09 (in house check Apr-13)	In house check: Apr-16
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-14)	In house check: Oct-15

Calibrated by:	Name Leif Klynsner	Function Laboratory Technician	Signature 
Approved by:	Name Katja Pokovic	Function Technical Manager	Signature 
			Issued: November 10, 2014

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: EX3-3592_Nov14

Page 1 of 11

	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report	Page 3(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2
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Glossary:


TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization ϕ	ϕ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\theta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\theta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not affect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; D_{x,y,z}; VR_{x,y,z}; A, B, C, D** are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f < 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

		Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report		Page 4(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID

EX3DV4 – SN:3592


November 10, 2014

Probe EX3DV4

SN:3592

Manufactured: September 18, 2006
Calibrated: November 10, 2014

Calibrated for DASY/EASY Systems
(Note: non-compatible with DASY2 system!)

	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report			Page 5(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID

EX3DV4- SN:3592

November 10, 2014

DASY/EASY - Parameters of Probe: EX3DV4 - SN:3592

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.48	0.47	0.40	± 10.1 %
DCP (mV) ^D	95.2	98.0	98.8	

Modulation Calibration Parameters


UID	Communication System Name		A dB	B dB V/μV	C	D dB	VR mV	Unc ^E (k=2)
0	CW	X	0.0	0.0	1.0	0.00	145.9	±3.3 %
		Y	0.0	0.0	1.0		156.9	
		Z	0.0	0.0	1.0		149.1	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X, Y, Z do not affect the E²-field uncertainty inside TSL (see Pages 5 and 6).

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report			Page 6(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID

EX3DV4- SN:3592

November 10, 2014

DASY/EASY - Parameters of Probe: EX3DV4 - SN:3592


Calibration Parameter Determined in Head Tissue Simulating Media

f (MHz) ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth (mm) ^G	Unct. (k=2)
2800	39.0	1.96	6.80	6.80	6.80	0.36	0.93	± 12.0 %
5250	35.9	4.71	4.63	4.63	4.63	0.35	1.80	± 13.1 %
5600	35.5	5.07	4.20	4.20	4.20	0.40	1.80	± 13.1 %
5750	35.4	5.22	4.34	4.34	4.34	0.40	1.80	± 13.1 %

^C Frequency validity above 300 MHz of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

^F At frequencies below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

^G Alpha/Depth are determined during calibration. SPFAC warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for frequencies between 3-8 GHz at any distance larger than half the probe tip diameter from the boundary.

		Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report		Page 7(20)
Author Data Andrew Becker		Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW
		IC ID		

EX3DV4 - SN:3592

November 10, 2014

DASY/EASY - Parameters of Probe: EX3DV4 - SN:3592

Calibration Parameter Determined in Body Tissue Simulating Media

f (MHz) ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth (mm)	Unct. (k=2)
2600	52.5	2.16	6.84	6.84	6.84	0.78	0.62	± 12.0 %
5250	48.9	5.36	4.06	4.06	4.06	0.45	1.90	± 13.1 %
5600	48.5	5.77	3.78	3.78	3.78	0.45	1.90	± 13.1 %
5750	48.3	5.94	3.81	3.81	3.81	0.50	1.90	± 13.1 %

^C Frequency validity above 300 MHz of ± 10% MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

^F At frequencies below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

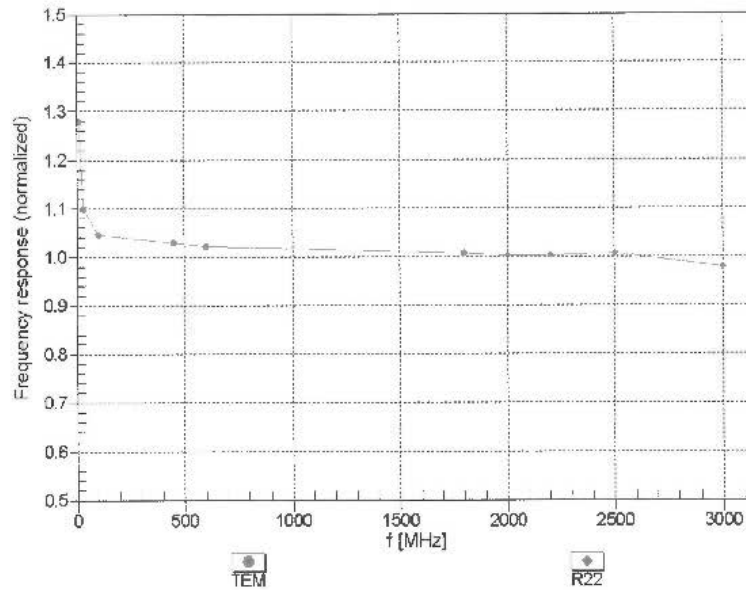
^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for frequencies between 3.6 GHz at any distance larger than half the probe tip diameter from the boundary.

BlackBerry	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report	Page 8(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2
FCC ID: L6ARFX100LW	IC ID	


EX3DV4- SN:3592

November 10, 2014

Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)



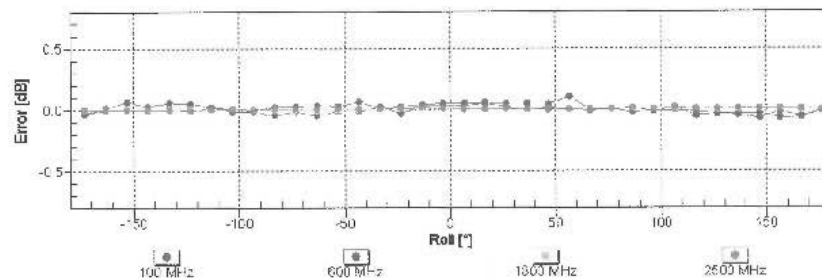
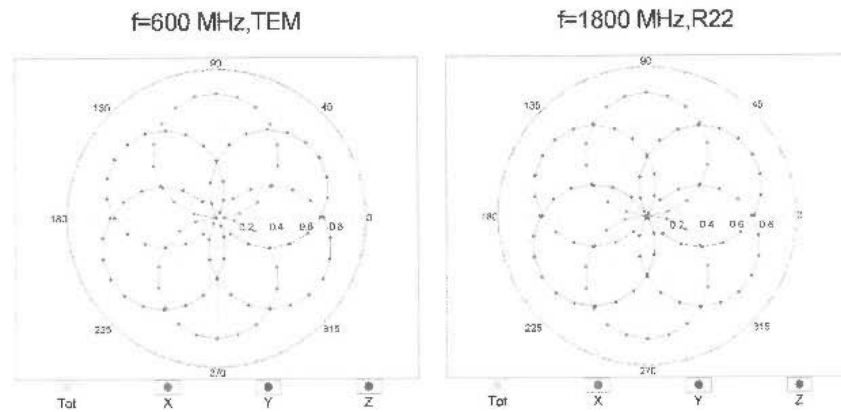
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)

	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report			Page 9(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID


EX3DV4- SN:3592

November 10, 2014

Receiving Pattern (ϕ), $\theta = 0^\circ$



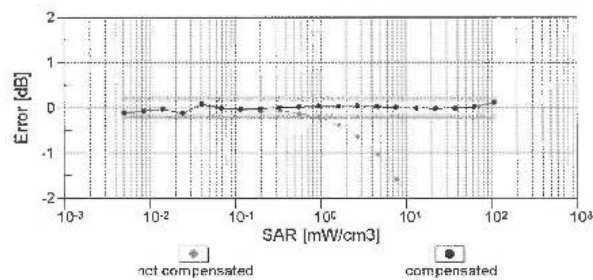
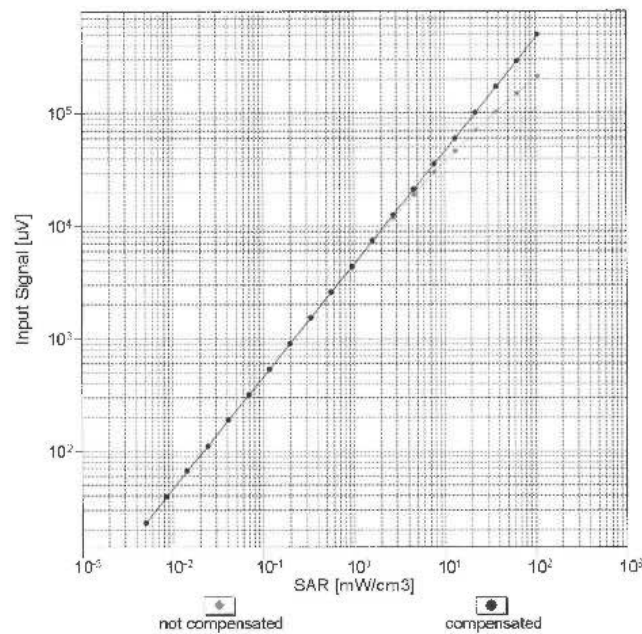
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report			Page 10(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID


EX3DV4-SN:3592

November 10, 2014

Dynamic Range $f(\text{SAR}_{\text{head}})$ (TEM cell, $f_{\text{eval}} = 1900 \text{ MHz}$)



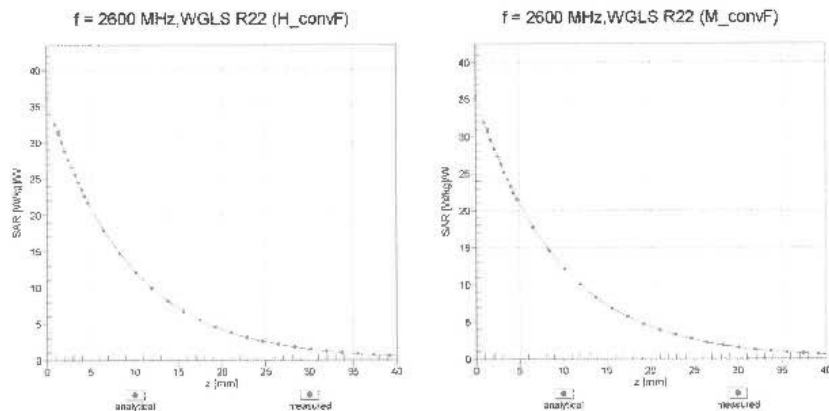
Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report			Page 11(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID

EX3DV4- SN:3592

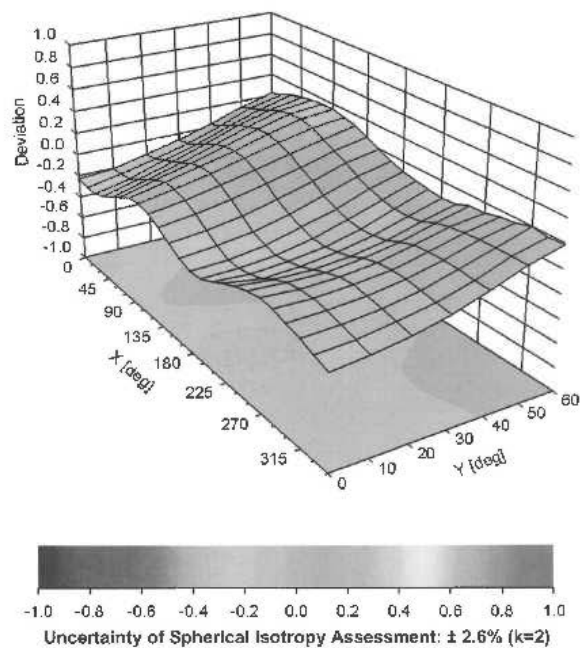
November 10, 2014


Conversion Factor Assessment



Deviation from Isotropy in Liquid

Error (ϕ, θ) , $f = 900 \text{ MHz}$



	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report			Page 12(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID

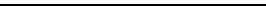
EX3DV4- SN:3592

November 10, 2014

DASY/EASY - Parameters of Probe: EX3DV4 - SN:3592

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	-13.3
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

		Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report		Page 13(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID

5000 Dipole

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Client **Blackberry Waterloo**

Certificate No: **D5GHzV2-1033_Nov13**

CALIBRATION CERTIFICATE																																															
Object	D5GHzV2 - SN: 1033																																														
Calibration procedure(s)	QA CAL-22.v2 Calibration procedure for dipole validation kits between 3-6 GHz																																														
Calibration date:	November 08, 2013																																														
<p>This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.</p> <p>All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.</p> <p>Calibration Equipment used (M&TE critical for calibration)</p> <table border="1"> <thead> <tr> <th>Primary Standards</th> <th>ID #</th> <th>Cal Date (Certificate No.)</th> <th>Scheduled Calibration</th> </tr> </thead> <tbody> <tr> <td>Power meter EPM-442A</td> <td>GB37480704</td> <td>09-Oct-13 (No. 217-01827)</td> <td>Oct-14</td> </tr> <tr> <td>Power sensor HP 8481A</td> <td>US37292783</td> <td>09-Oct-13 (No. 217-01827)</td> <td>Oct-14</td> </tr> <tr> <td>Power sensor HP 8481A</td> <td>MY41092317</td> <td>09-Oct-13 (No. 217-01828)</td> <td>Oct-14</td> </tr> <tr> <td>Reference 20 dB Attenuator</td> <td>SN: 5058 (20k)</td> <td>04-Apr-13 (No. 217-01736)</td> <td>Apr-14</td> </tr> <tr> <td>Type-N mismatch combination</td> <td>SN: 5047.3 / 06327</td> <td>04-Apr-13 (No. 217-01739)</td> <td>Apr-14</td> </tr> <tr> <td>Reference Probe ES3DV3</td> <td>SN: 3205</td> <td>28-Dec-12 (No. ES3-3205_Dec12)</td> <td>Dec-13</td> </tr> <tr> <td>DAE4</td> <td>SN: 601</td> <td>25-Apr-13 (No. DAE4-601_Apr13)</td> <td>Apr-14</td> </tr> </tbody> </table> <table border="1"> <thead> <tr> <th>Secondary Standards</th> <th>ID #</th> <th>Check Date (in house)</th> <th>Scheduled Check</th> </tr> </thead> <tbody> <tr> <td>RF generator R&S SMT-06</td> <td>103005</td> <td>04-Aug-99 (in house check Oct-13)</td> <td>In house check: Oct-15</td> </tr> <tr> <td>Network Analyzer HP 8753E</td> <td>US37390585 S4206</td> <td>18-Oct-01 (in house check Oct-13)</td> <td>In house check: Oct-14</td> </tr> </tbody> </table>				Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration	Power meter EPM-442A	GB37480704	09-Oct-13 (No. 217-01827)	Oct-14	Power sensor HP 8481A	US37292783	09-Oct-13 (No. 217-01827)	Oct-14	Power sensor HP 8481A	MY41092317	09-Oct-13 (No. 217-01828)	Oct-14	Reference 20 dB Attenuator	SN: 5058 (20k)	04-Apr-13 (No. 217-01736)	Apr-14	Type-N mismatch combination	SN: 5047.3 / 06327	04-Apr-13 (No. 217-01739)	Apr-14	Reference Probe ES3DV3	SN: 3205	28-Dec-12 (No. ES3-3205_Dec12)	Dec-13	DAE4	SN: 601	25-Apr-13 (No. DAE4-601_Apr13)	Apr-14	Secondary Standards	ID #	Check Date (in house)	Scheduled Check	RF generator R&S SMT-06	103005	04-Aug-99 (in house check Oct-13)	In house check: Oct-15	Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-13)	In house check: Oct-14
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Calibrated by:	Name Claudio Leubler	Function Laboratory Technician	Signature 																																												
Approved by:	Katja Pokovic	Technical Manager																																													
			Issued: November 8, 2013																																												
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Certificate No: D5GHzV2-1033_Nov13

Page 1 of 8

	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report	Page 14(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2
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Glossary:

TSL tissue simulating liquid
ConvF sensitivity in TSL / NORM x,y,z
N/A not applicable or not measured

Calibration is Performed According to the Following Standards:

- IEC 62209-2, "Evaluation of Human Exposure to Radio Frequency Fields from Handheld and Body-Mounted Wireless Communication Devices in the Frequency Range of 30 MHz to 6 GHz: Human models, Instrumentation, and Procedures"; Part 2: "Procedure to determine the Specific Absorption Rate (SAR) for including accessories and multiple transmitters", March 2010
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"
- IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013

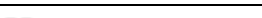
Additional Documentation:

- DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

		Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report		Page 15(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.7
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy = 4.0 mm, dz = 1.4 mm	Graded Ratio = 1.4 (Z direction)
Frequency	5200 MHz ± 1 MHz 5500 MHz ± 1 MHz 5800 MHz ± 1 MHz	

Head TSL parameters at 5200 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	36.0	4.66 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	35.0 ± 6 %	4.46 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5200 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	7.99 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	79.4 W/kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.28 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	22.6 W/kg ± 19.5 % (k=2)


Head TSL parameters at 5500 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.6	4.96 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	34.6 ± 6 %	4.75 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5500 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.51 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	84.4 W / kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.41 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	23.9 W/kg ± 19.5 % (k=2)

	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report			Page 16(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID

Head TSL parameters at 5800 MHz


The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.3	5.27 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	34.2 ± 6 %	5.06 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C	—	—

SAR result with Head TSL at 5800 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.01 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	79.4 W/kg ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.28 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	22.6 W/kg ± 19.5 % (k=2)

	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report			Page 17(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID

Appendix

Antenna Parameters with Head TSL at 5200 MHz

Impedance, transformed to feed point	49.1 Ω - 9.6 $j\Omega$
Return Loss	- 20.3 dB

Antenna Parameters with Head TSL at 5500 MHz

Impedance, transformed to feed point	50.3 Ω - 4.1 $j\Omega$
Return Loss	- 27.7 dB

Antenna Parameters with Head TSL at 5800 MHz

Impedance, transformed to feed point	57.8 Ω - 4.0 $j\Omega$
Return Loss	- 21.8 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.213 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	July 09, 2004

	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report			Page 18(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID

DASY5 Validation Report for Head TSL

Date: 08.11.2013

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN: 1033

Communication System: UID 0 - CW ; Frequency: 5200 MHz, Frequency: 5500 MHz, Frequency: 5800 MHz

Medium parameters used: $f = 5200$ MHz; $\sigma = 4.46$ S/m; $\epsilon_r = 35$; $\rho = 1000$ kg/m³,
Medium parameters used: $f = 5500$ MHz; $\sigma = 4.75$ S/m; $\epsilon_r = 34.6$; $\rho = 1000$ kg/m³,
Medium parameters used: $f = 5800$ MHz; $\sigma = 5.06$ S/m; $\epsilon_r = 34.2$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: EX3DV4 - SN3503; ConvF(5.41, 5.41, 5.41); Calibrated: 28.12.2012, ConvF(4.91, 4.91, 4.91); Calibrated: 28.12.2012, ConvF(4.81, 4.81, 4.81); Calibrated: 28.12.2012;
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 25.04.2013
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- DASY52 52.8.7(1137); SEMCAD X 14.6.10(7164)

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5200 MHz/Zoom Scan,

dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm

Reference Value = 64.635 V/m; Power Drift = -0.04 dB

Peak SAR (extrapolated) = 29.5 W/kg

SAR(1 g) = 7.99 W/kg; SAR(10 g) = 2.28 W/kg

Maximum value of SAR (measured) = 18.4 W/kg

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5500 MHz/Zoom Scan,

dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm

Reference Value = 64.397 V/m; Power Drift = 0.02 dB

Peak SAR (extrapolated) = 33.8 W/kg

SAR(1 g) = 8.51 W/kg; SAR(10 g) = 2.41 W/kg

Maximum value of SAR (measured) = 20.3 W/kg

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5800 MHz/Zoom Scan,


dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm

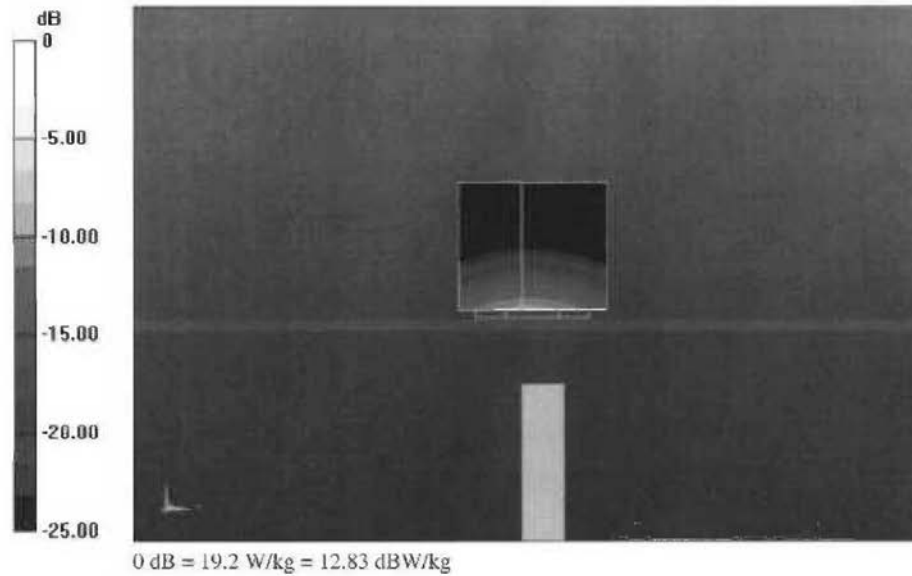
Reference Value = 61.128 V/m; Power Drift = 0.08 dB


Peak SAR (extrapolated) = 33.0 W/kg

SAR(1 g) = 8.01 W/kg; SAR(10 g) = 2.28 W/kg

Maximum value of SAR (measured) = 19.2 W/kg

	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report			Page 19(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID



	Document Appendix D for the BlackBerry® Smartphone Model RFX101LW SAR Report			Page 20(20)
Author Data Andrew Becker	Dates of Test March 24-26, 2014 December 8-12, 2014	Test Report No RTS-6046-1404-01Rev 2	FCC ID: L6ARFX100LW	IC ID

Impedance Measurement Plot for Head TSL

